

### 2NM50-S

#### Power MOSFET

# 2.0A, 500V N-CHANNEL SUPER-JUNCTION MOSFET

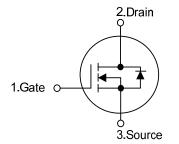
#### DESCRIPTION

The **UTC 2NM50-S** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

#### FEATURES

- \*  $R_{DS(ON)}$  < 2.9 $\Omega$  @  $V_{GS}$  = 10V,  $I_D$  =1.0A
- \* Fast switching capability
- \* Avalanche energy specified
- \* Improved dv/dt capability, high ruggedness

#### SYMBOL

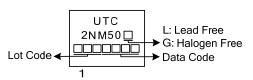


# TO-220F1

#### ORDERING INFORMATION

Ordering Number		Daakaaa	Pin Assignment			Decking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
2NM50L-TF1-T	2NM50G-TF1-T	TO-220F1	G	D	S	Tube	
2NM50L-TN3-R	2NM50G-TN3-R	TO-252	G	D	S	Tape Reel	
Note: Pin Assignment: G: Gate D: Drain S: Source							
2NM50L-TF1-T (1)Packing Type (2)Package Type (3)Green Package		(1) T: Tube, R: Tape Reel (2) TF1: TO-220F1, TN3: TO-252 (3) G: Halogen Free and Lead Free, L: Lead Free					

#### MARKING



#### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>c</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V <sub>DSS</sub>	500	V
Gate-Source Voltage		V <sub>GSS</sub>	±30	V
Drain Current (T <sub>C</sub> =25°C)	Continuous	I <sub>D</sub>	2.0	А
	Pulsed (Note 2)	I <sub>DM</sub>	8.0	А
Avalanche Current (Note 2)		I <sub>AR</sub>	1.1	А
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	87	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	5.2	V/ns
Power Dissipation	TO-220F1	D	23	W
	TO-252	PD	50	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L=144mH,  $I_{AS}$ =1.1A,  $V_{DD}$ =50V,  $R_G$ =25  $\Omega$ , Starting  $T_J$  = 25°C

4.  $I_{SD}\leq 2.0A$ , di/dt $\leq 200A/\mu s$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$ 

#### THERMAL CHARACTERISTICS

		i		
PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220F1	٥	62.5	°C/W
	TO-252	θ <sub>JA</sub>	110	°C/W
Junction to Case	TO-220F1	0	5.5	°C/W
	TO-252	θ <sub>JC</sub>	2.5	°C/W



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#### ■ ELECTRICAL CHARACTERISTICS (T<sub>J</sub>=25°C, unless otherwise specified)

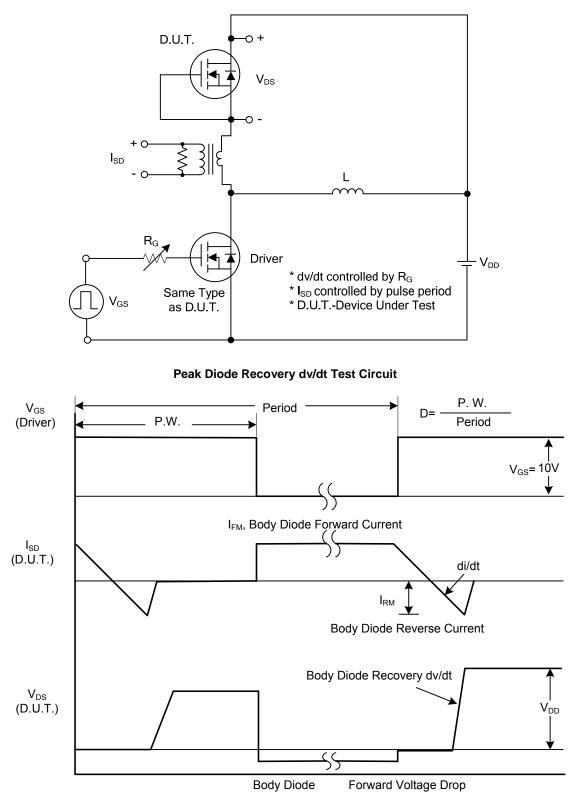
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA	500			V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> = 500V, V <sub>GS</sub> = 0V			10	μA
Gate-Source Leakage Current		$V_{GS} = 30V, V_{DS} = 0V$			100	nA
Reverse	I <sub>GSS</sub>	$V_{GS}$ = -30V, $V_{DS}$ = 0V			-100	nA
ON CHARACTERISTICS						
Gate Threold Voltage	V <sub>GS(TH)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.5	V
Static Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> =1.0A			2.9	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C <sub>ISS</sub>			167		рF
Output Capacitance	Coss	$V_{DS}$ =25V, $V_{GS}$ =0V, f =1MHz		85		рF
Reverse Transfer Capacitance	C <sub>RSS</sub>			13		рF
SWITCHING CHARACTERISTICS						
Total Gate Charge (Note 1)	Q <sub>G</sub>			23		nC
Gate to Source Charge	$Q_{GS}$	$V_{DS}=50V$ , $V_{GS}=10V$ , $I_{D}=1.3A$ $-I_{G}=100\mu A$ (Note 1, 2)		3.5		nC
Gate to Drain Charge	$Q_{GD}$	IG-100μΑ (Note 1, 2)		6		nC
Turn-ON Delay Time (Note 1)	t <sub>D (ON)</sub>			37		ns
Rise Time	t <sub>R</sub>	V <sub>DD</sub> =30V, V <sub>GS</sub> =10V, I <sub>D</sub> =0.5A,		25		ns
Turn-OFF Delay Time	t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		70		ns
Fall-Time	t⊢			30		ns
SOURCE- DRAIN DIODE RATINGS AND CH	ARACTERIS	TICS	_			
Maximum Body-Diode Continuous Current	Is				2.0	Α
Maximum Body-Diode Pulsed Current	I <sub>SM</sub>				8.0	А
Drain-Source Diode Forward Voltage (Note 1)	V <sub>SD</sub>	I <sub>S</sub> =2.0A, V <sub>GS</sub> =0V			1.4	V
Body Diode Reverse Recovery Time (Note 1)	t <sub>rr</sub>	I <sub>S</sub> =2.0A, V <sub>GS</sub> =0V,		190		nS
Body Diode Reverse Recovery Charge	Qrr	dI <sub>F</sub> /dt=100A/µs		0.9		μC

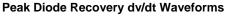
Notes: 1. Pulse Test: Pulse width  $\leq$  300µs, Duty cycle $\leq$ 2%.

2. Essentially independent of operating temperature.



#### TEST CIRCUITS AND WAVEFORMS

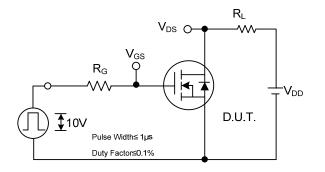


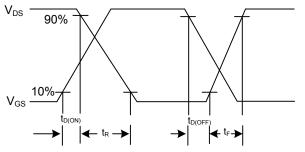




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#### ■ TEST CIRCUITS AND WAVEFORMS (Cont.)





Switching Test Circuit



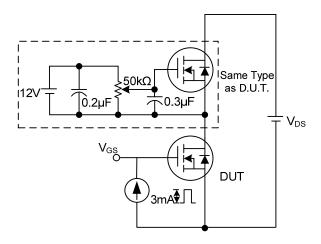
 $\mathsf{Q}_\mathsf{G}$ 

 $\mathsf{Q}_{\mathsf{GD}}$ 

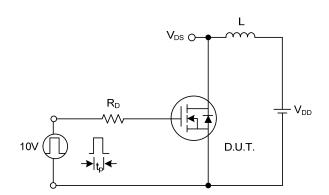
 $\mathsf{V}_{\mathsf{GS}}$ 

10V

Q<sub>GS</sub>



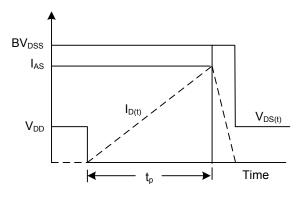
Gate Charge Test Circuit



**Unclamped Inductive Switching Test Circuit** 

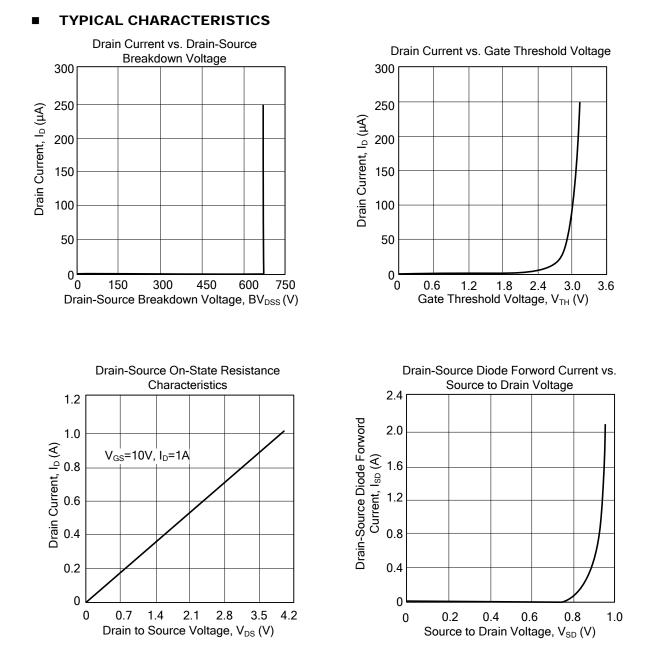
Gate Charge Waveform

Charge



**Unclamped Inductive Switching Waveforms** 





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